

Applicant:

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Title:

SUBSTRATE INSPECTING METHOD AND SUBSTRATE

INSPECTING APPARATUS USING THE METHOD

Application No.:

10/786,468

Filing Date:

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Examiner:

Arbes, Carl J.

Art Unit:

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AMENDMENT AND REPLY UNDER 37 C.F.R. 1.312

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Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

This communication is being filed after receipt of a Notice of Allowance dated April 24, 2006, concerning the above-referenced patent application.

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this document.

Remarks/Arguments begin on page 7 of this document.

Please amend the application as follows: